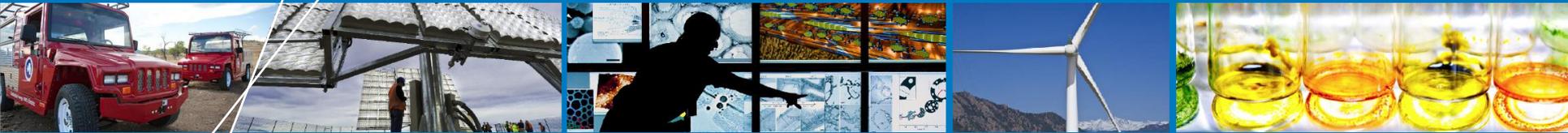
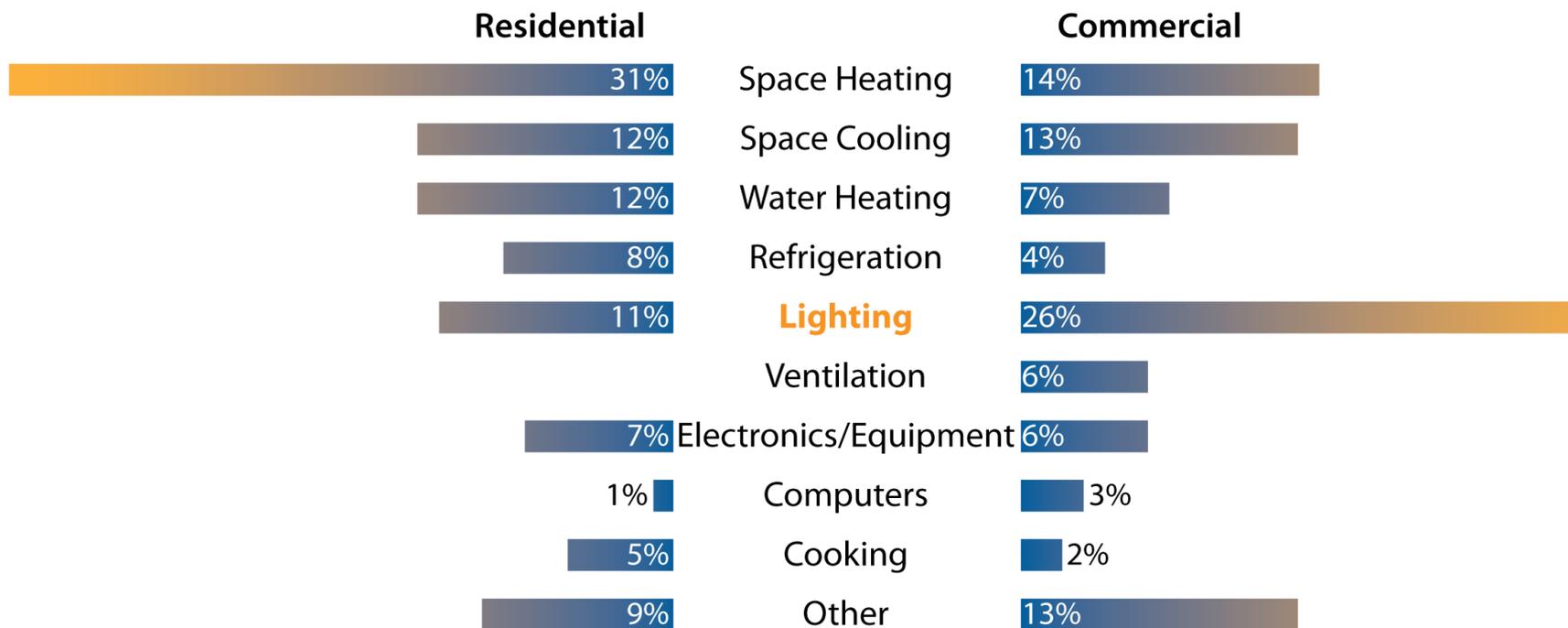


$\text{Al}_x\text{In}_{1-x}\text{P}$ Amber LEDs for Solid-State Lighting



Kirstin Alberi
Yoriko Morita

Breakdown of Buildings Energy Use



Source: *Energy Efficiency Trends in Residential and Commercial Buildings*, DOE Energy Efficiency and Renewable Energy Report, 2008

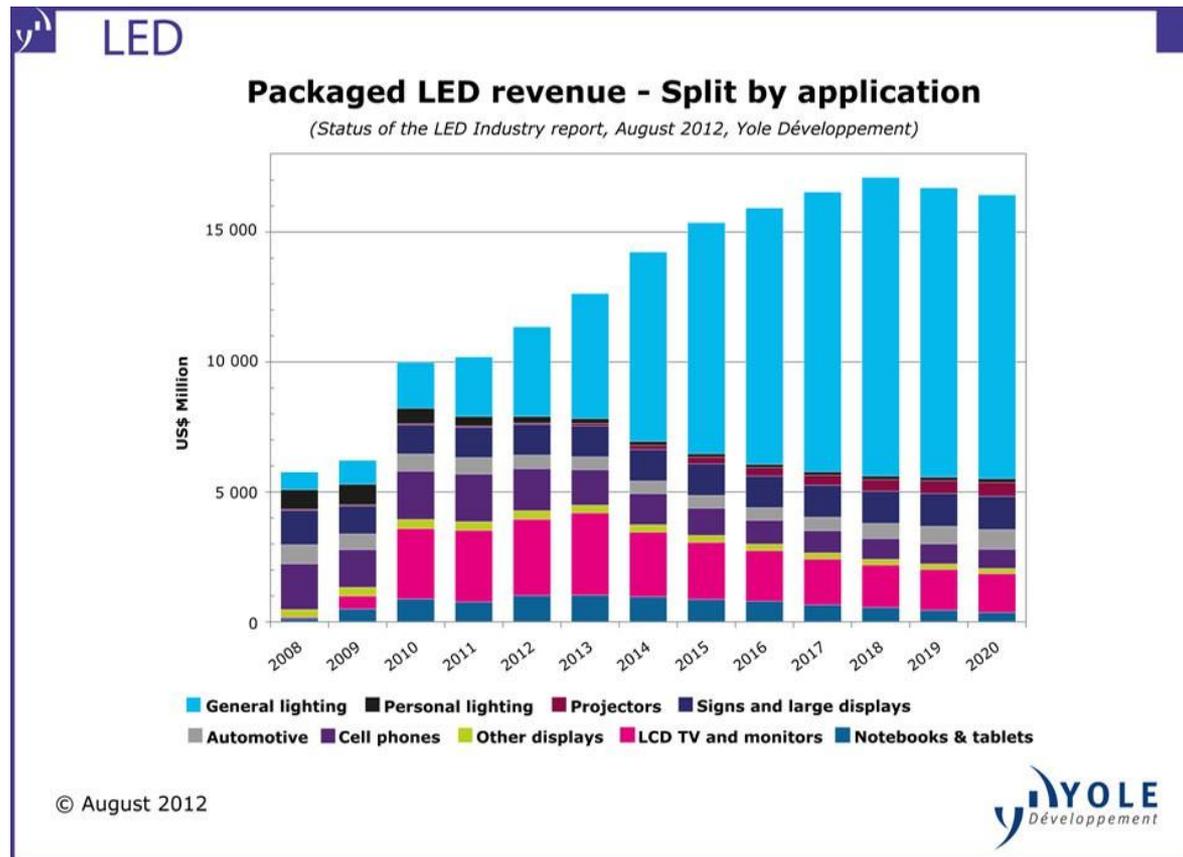
Switching to solid-state lamps is forecast to result in a 46% reduction in lighting energy consumption by 2030.

- Cumulative energy savings 2010-2030: 2,700 TWh
- Cumulative cost savings 2010-2030: \$250B

Source: *Energy Savings Potential of Solid-State Lighting in General Illumination Applications*, DOE Energy Efficiency and Renewable Energy Buildings Report, 2012

Packaged LED Market and Revenues

Packaged LED revenue is projected to reach \$17.1 billion by 2018



Source: Status of the LED Industry, Yole Développement and EPIC, 2012

DOE – EERE Mandate



Solid-State Lighting
Research and Development:

Multi-Year Program Plan

April 2012

Prepared for:
Lighting Research and Development
Building Technologies Program

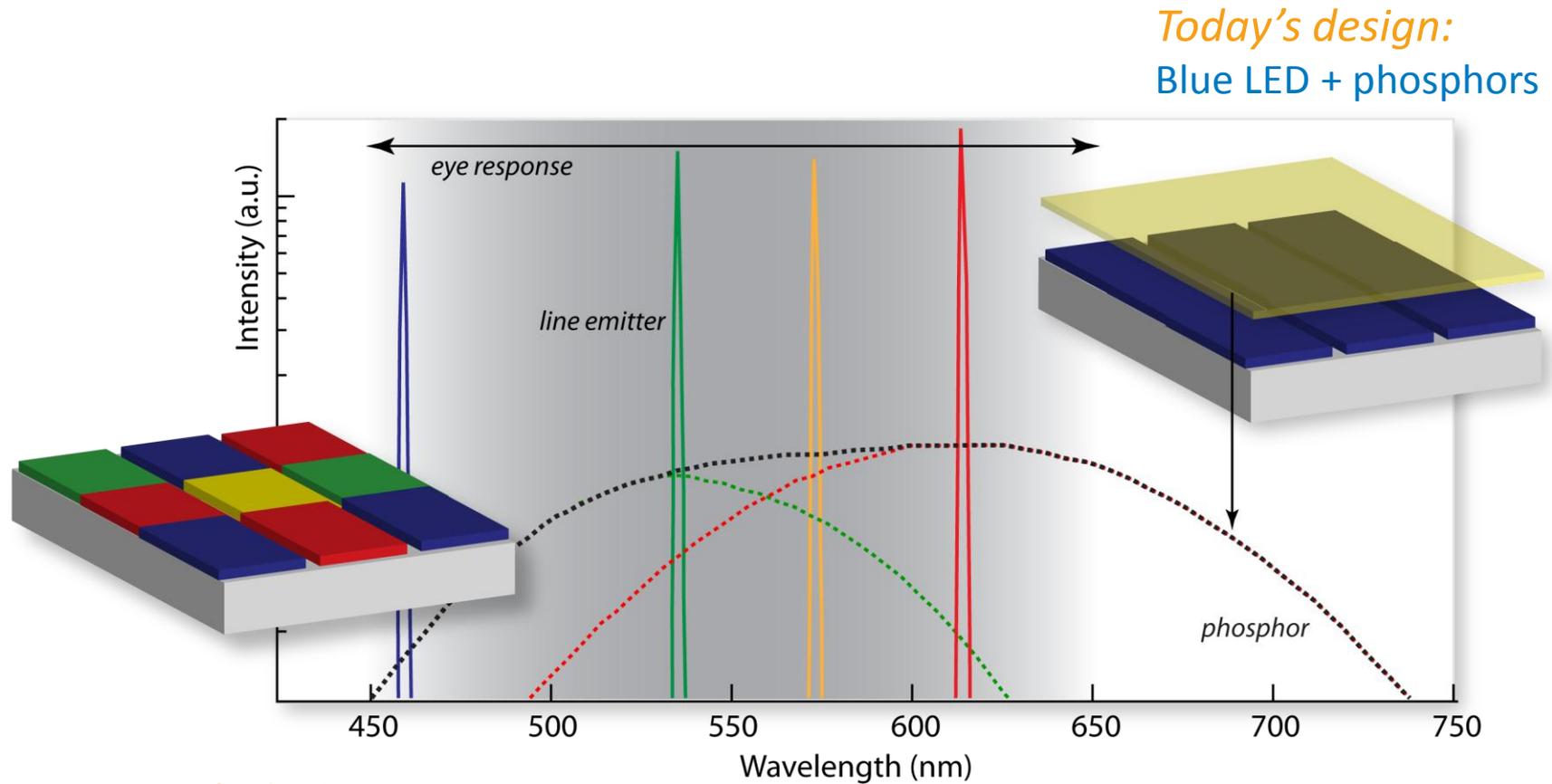
U.S. DEPARTMENT OF
ENERGY

Energy Efficiency &
Renewable Energy

“By 2025, develop advanced solid-state lighting technologies that...are much more energy efficient, longer lasting, and cost-competitive by targeting a product system efficiency of 50 percent with lighting that **closely reproduces the visible portions of the sunlight spectrum.**”

- *US Department of Energy*

Solid-State Lamp Designs



Tomorrow's design:
Combination of individual LEDs

This approach requires each of the LEDs also be highly efficient!

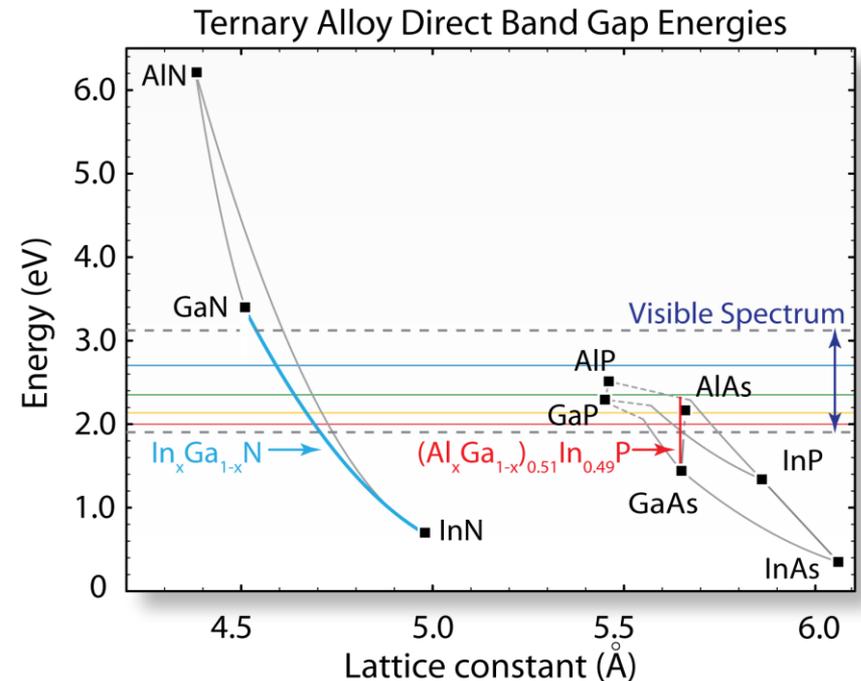
Conventional Materials for Visible LEDs

$\text{In}_x\text{Ga}_{1-x}\text{N}$

- Suitable for short λ emission
- Addition of In reduces EQE

$(\text{Al}_x\text{Ga}_{1-x})_{0.51}\text{In}_{0.49}\text{P}$

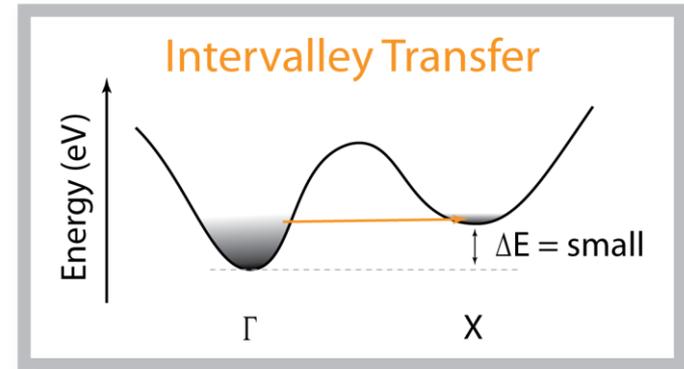
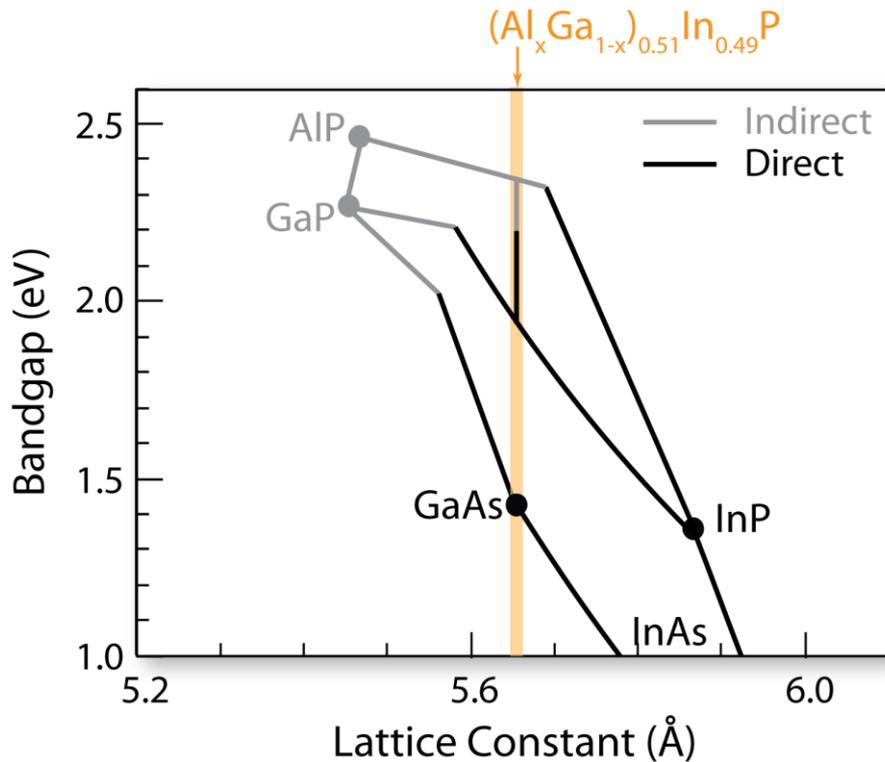
- Lattice-matched to GaAs
- Cannot reach high efficiencies at amber/green λ due to fundamental material issues.



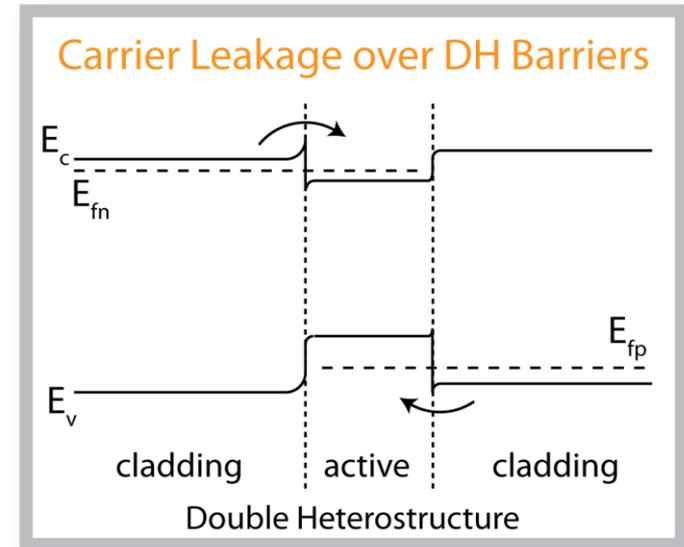
Wavelength (nm)	Material	Current EQE @ 35 A/cm ²	2020 Target EQE
440-460	InGaN	75%	81%
520-540	InGaN	30%	
580-595	AlGaInP	10%	
610-620	AlGaInP	52%	

Fundamental Material Properties Limit $(\text{Al}_x\text{Ga}_{1-x})_{0.51}\text{In}_{0.49}\text{P}$ LEDs

Light emission at shorter wavelengths is limited by two mechanisms.



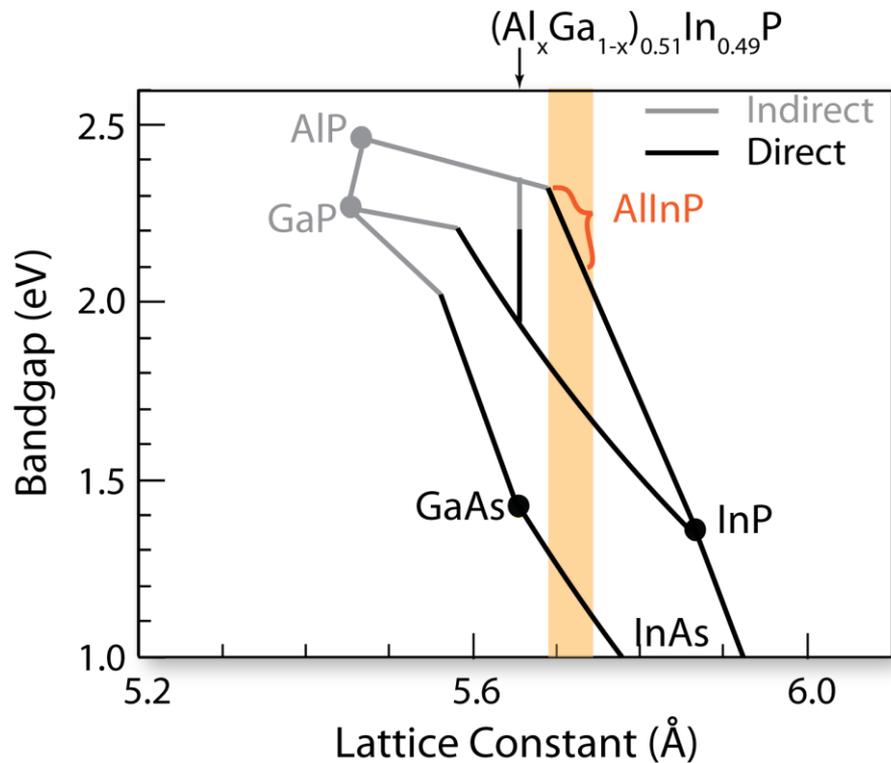
Electrons move to the X conduction band when the composition is near the direct-indirect crossover.



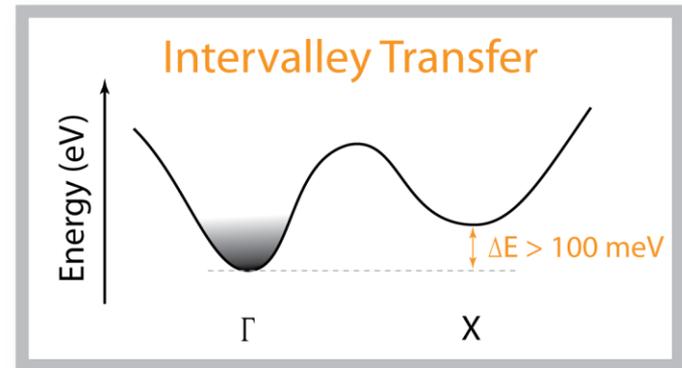
Carrier confinement potentials are important

$\text{Al}_x\text{In}_{1-x}\text{P}$ for Amber LEDs

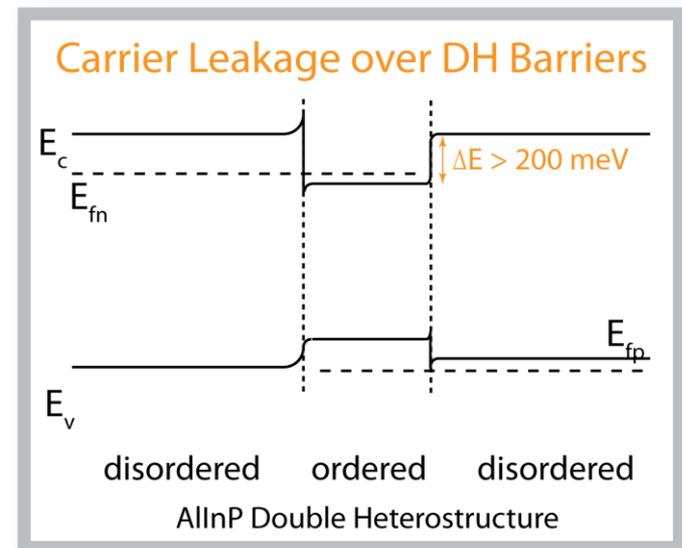
The properties of $\text{Al}_x\text{In}_{1-x}\text{P}$ offer a way to reduce the impact of these loss mechanisms.



Material	Crossover	Emission λ Limit
$(\text{Al}_x\text{Ga}_{1-x})_{0.51}\text{In}_{0.49}\text{P}$	2.23 eV	582 nm
$\text{Al}_x\text{In}_{1-x}\text{P}$	2.32 eV	558 nm



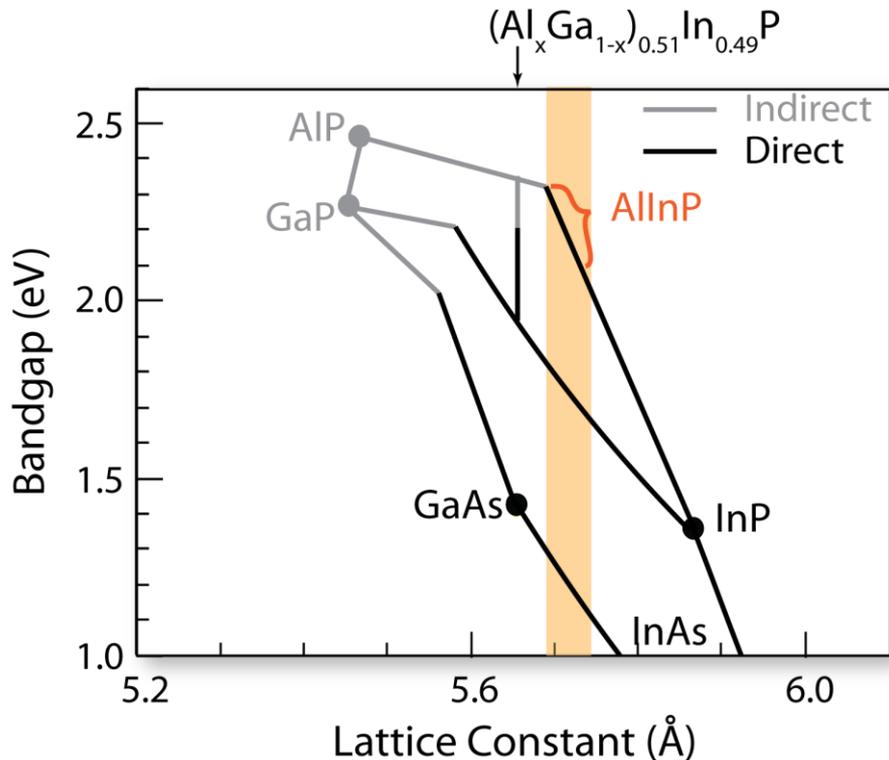
$\text{Al}_x\text{In}_{1-x}\text{P}$ has the highest Γ -X crossover of any non-nitride III-V alloy (2.3 eV)



Disordered/ordered/disordered double heterostructures provide electron

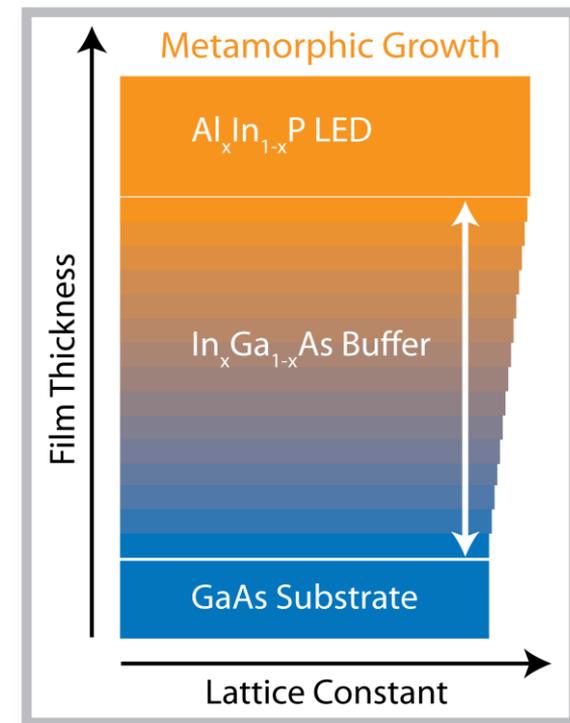
Past Barriers for $\text{Al}_x\text{In}_{1-x}\text{P}$ LEDs

A number of problems have until now prevented the use of $\text{Al}_x\text{In}_{1-x}\text{P}$ as the light-emitting material in LEDs



Oxygen contamination

Modern improvements in reactor design and precursor purity have reduced this problem.

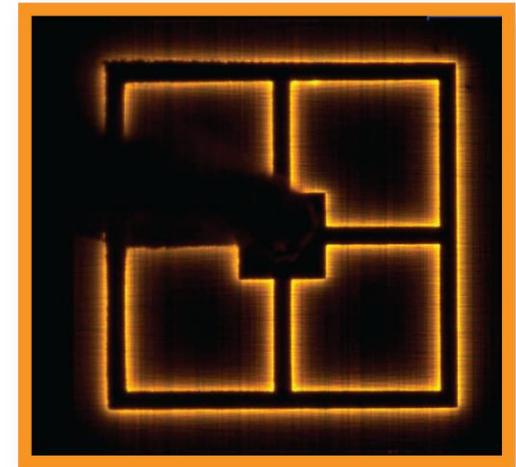


The lattice-mismatch with the substrate can be accommodated with a metamorphic buffer.

$\text{Al}_x\text{In}_{1-x}\text{P}$ LED Performance

$\text{Al}_x\text{In}_{1-x}\text{P}$ LEDs were compared to red-emitting lattice-matched $\text{Ga}_{0.5}\text{In}_{0.5}\text{P}$ LED standards of the same structure in order to gauge relative efficiency.

- This approach is used to understand the efficiency potential without having to optimized the structure for current spreading and light extraction.
- Extrapolation to optimized efficiencies:
 - Lattice-matched $\text{Ga}_{0.5}\text{In}_{0.5}\text{P}$ LED = 50% EQE
 - Our best $\text{Al}_x\text{In}_{1-x}\text{P}$ LED (595 nm) is 39% as efficient as the $\text{Ga}_{0.5}\text{In}_{0.5}\text{P}$ standard.
 - These results suggest that these $\text{Al}_x\text{In}_{1-x}\text{P}$ LEDs could have absolute EQEs as high as 20%.



AlInP LED (595 nm emission)

Work is ongoing to optimize the material and structure for LED applications.

Current NREL IP Status

- Record of Invention (ROI) 09-36: Patent application pending in US
- ROI 09-59: Patent application pending in US and Canada
- ROI 10-64: Patent application pending in US, Canada, Japan, and Europe

(12) INTERNATIONAL APPLICATION PUBLISHED UNDER THE PATENT COOPERATION TREATY (PCT)

(19) World Intellectual Property Organization
International Bureau

(43) International Publication Date
21 October 2010 (21.10.2010)



(10) International Publication Number
WO 2010/121057 A1

(51) International Patent Classification:
H01L 31/00 (2006.01)

(21) International Application Number:
PCT/US2010/031279

(22) International Filing Date:
15 April 2010 (15.04.2010)

(25) Filing Language:
English

(26) Publication Language:
English

(30) Priority Data:
61/169,980 16 April 2009 (16.04.2009) US

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(81) Designated States (unless otherwise indicated, for every kind of national protection available): AE, AG, AL, AM, AO, AT, AU, AZ, BA, BB, BG, BH, BR, BW, BY, BZ, CA, CH, CL, CN, CO, CR, CU, CZ, DE, DK, DM, DO, DZ, EC, EE, EG, ES, FI, GB, GD, GE, GH, GM, GT, HN, HR, HU, ID, IL, IN, IS, JP, KE, KG, KM, KN, KP, KR, KZ, LA, LC, LK, LR, LS, LT, LU, LY, MA, MD, ME, MG, MK, MN, MW, MX, MY, MZ, NA, NG, NI, NO, NZ, OM, PE, PG, PH, PL, PT, RO, RS, RU, SC, SD, SE, SG, SK, SL, SM, ST, SV, SY, TH, TJ, TM, TN, TR, TT, TZ, UA, UG, US, UZ, VC, VN, ZA, ZM, ZW.

[Continued on next page]

(54) Title: LATTICE-MISMATCHED GaInP LED DEVICES AND METHODS OF FABRICATING SAME

(57) Abstract: A method (100) of fabricating an LED or the active regions of an LED and an LED (200). The method includes growing, depositing or otherwise providing a bottom cladding layer (208) of a selected semiconductor alloy with an adjusted bandgap provided by intentionally disordering the structure of the cladding layer (208). A first active layer (202) may be grown above the bottom cladding layer (208) wherein the first active layer (202) is fabricated of the same semiconductor alloy, with however, a partially ordered structure. The first active layer (202) will also be fabricated to include a selected n or p type doping. The method further includes growing a second active layer (204) above the first active layer (202) where the second active layer (204) is fabricated from the same semiconductor alloy.

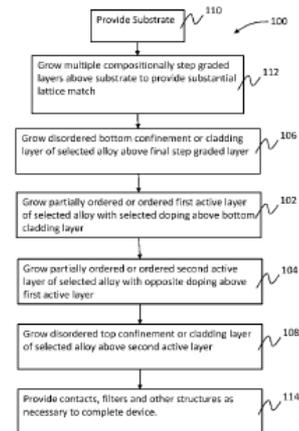


Fig. 1

WO 2010/121057 A1

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- **Energy Innovation Portal listing**

<http://techportal.eere.energy.gov/technology.do/techID=216>